EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	. 3	(external with test\$3 with data with scan\$3 with (integrated adj circuit) with (return\$3 or output\$4) with result\$1)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR .	OFF	2007/09/30 23:47
L3	0	(low with voltage with below with time with period with timeout)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/09/30 23:48
L4	0	(low with voltage with below with time with period) same timeout	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR .	OFF	2007/09/30 23:48
L5	12	(low with voltage with below with time) same timeout	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/09/30 23:50
L7	0	(low with voltage with timeout) with (integrated adj circuit) with pin	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/09/30 23:51
L8	0	(low with voltage with timeout) with (integrated adj circuit)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR .	OFF	2007/09/30 23:51
L9	0	(low with voltage with timeout) same (integrated adj circuit)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/09/30 23:52
L10	22	(low with voltage with timeout) and (integrated adj circuit)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/09/30 23:56

EAST Search History

L11	0	(low with voltage with timeout) and ((integrated adj circuit) with pin)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR .	OFF	2007/09/30 23:52
L12	2	(below with low with voltage with timeout) and (integrated adj circuit)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/10/01 00:01
L13	9	(below with low with voltage with timeout)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/10/01 01:30
L15	0	(714/724.ccls.) and (integrated adj circuit) and ((input adj output) with pin with single) and (external with test\$3 with circuit\$2) and ((logic or voltage\$1) with threshold\$1)	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/01 01:34
L16	0	(714/738.ccls.) and (integrated adj circuit) and ((input adj output) with pin with single) and (external with test\$3 with circuit\$2) and ((logic or voltage\$1) with threshold\$1)	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/01 01:34
L17	0	(714/715.ccls.) and (integrated adj circuit) and ((input adj output) with pin with single) and (external with test\$3 with circuit\$2) and ((logic or voltage\$1) with threshold\$1)	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/01 01:34
L18	0	(714/25.ccls.) and (integrated adj circuit) and ((input adj output) with pin with single) and (external with test\$3 with circuit\$2) and ((logic or voltage\$1) with threshold\$1)	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/01 01:34
L19	0	(714/27.ccls.) and (integrated adj circuit) and ((input adj output) with pin with single) and (external with test\$3 with circuit\$2) and ((logic or voltage\$1) with threshold\$1)	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/01 01:35
L20	. 0	(714/726.ccls.) and (integrated adj circuit) and ((input adj output) with pin with single) and (external with test\$3 with circuit\$2) and ((logic or voltage\$1) with threshold\$1)	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/01 01:35

EAST Search History

L21	. 0	(714/727.ccls.) and (integrated adj circuit) and ((input adj output) with pin with single) and (external with test\$3 with circuit\$2) and ((logic or voltage\$1) with threshold\$1)	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/01 01:36
L22	0	(714/729.ccls.) and (integrated adj circuit) and ((input adj output) with pin with single) and (external with test\$3 with circuit\$2) and ((logic or voltage\$1) with threshold\$1)	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/01 01:36
L23	0	(714/730.ccls.) and (integrated adj circuit) and ((input adj output) with pin with single) and (external with test\$3 with circuit\$2) and ((logic or voltage\$1) with threshold\$1)	US-PGPUB; USPAT; USOCR	OR .	OFF	2007/10/01 01:36
L24	7	(integrated adj circuit) and ((input adj output) with pin with single) and (external with test\$3 with circuit\$2) and ((logic or voltage\$1) with threshold\$1)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/10/01 01:37
L25	1	winter-rudi-de.in.	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/01 01:40

DC

	ſ		i
	©	נ	4
		5	RELEASE 2.4
,	X	3	E
	h		

IEEEXplore# Search History

Home | Login | Logour | Access Information | Alerts | Purchase History |

Welcome United States Patent and Trademark Office

Carl Sitemap | Help

SUPPORT

IEEE XPLORE GUIDE

SEARCH

BROWSE

Story
Ä
Session
arch

□. Sea

Edit an existing query or compose a new query in the Search Query

Display.

Select a search number (#) to:

- Add a query to the Search Query Display
- Combine search queries using AND, OR, or NOT
- Delete a search
- Run a search

Mon, 1 Oct 2007, 1:48:05 AM EST

Search Query Display

(integrated circuit-and-single input output pin)-and-external test circuitry #

Recent Search Queries

Results

Indexed by

© Copyright 2006 IEEE - All Rights Reserved Help Contact Us Privacy & Security IEEE.org

10/1/07

Subscribe (Full Service) Register (Limited Service, Free) Login

Search: The ACM Digital Library The Guide
+"integrated circuit", +"single input output pin", +"external te



Nothing Found

Your search for +"integrated circuit", +"single input output pin", +"external test circuitry" did not return any results.

You may want to try an Advanced Search for additional options.

Please review the Quick Tips below or for more information see the Search Tips.

Quick Tips

• Enter your search terms in lower case with a space between the terms.

sales offices

You can also enter a full question or concept in <u>plain language</u>.

Where are the sales offices?

 Capitalize <u>proper nouns</u> to search for specific people, places, or products.

John Colter, Netscape Navigator

Enclose a <u>phrase</u> in double quotes to search for that exact phrase.

"museum of natural history" "museum of modern art"

Narrow your searches by using a + if a search term <u>must appear</u> on a page.

museum +art

• Exclude pages by using a - if a search term <u>must not appear</u> on a page.

museum -Paris

Combine these techniques to create a specific search query. The better your description of the information you want, the more relevant your results will be.

museum +"natural history" dinosaur -Chicago

The ACM Portal is published by the Association for Computing Machinery. Copyright © 2007 ACM, Inc.

<u>Terms of Usage Privacy Policy Code of Ethics Contact Us</u>

PALM Intranet

Application Number

Submit

IDS Flag Clearance for Application 10519346



Content	Mailroom Date	Entry Number	IDS Review	Last Modified	Reviewer
WIDS	2004-12-21	24	Y 🗹	2007-09-30 13:47:56.0	dgandhi
Update		***		-	•